

Vanta[™] iX In-Line XRF Analyzer for Automated Material Analysis



Keep Your Process Up to Speed

Accuracy You Can Count On

The Olympus Vanta[™] iX in-line X-ray fluorescence (XRF) analyzer automates material analysis and alloy ID on the manufacturing line, delivering instant results for real-time process monitoring and 100% alloy identification (ID). Designed to operate 24/7, the analyzer can be configured to deliver pass/ fail results, accurate grade ID, and material chemistry.

- High resolution: ID a range of alloy grades-including light and heavy elements
- Fast, accurate results: the analyzer provides speed, stability, and a high-count rate
- Efficient: features a silicon drift detector (SDD) and the proven Axon Technology™ found in every Vanta analyzer

100% Inspection for Metal Fabrication

For organizations adopting Industry 4.0 practices and 24/7 process control to verify alloys, the Vanta iX analyzer delivers material verification and lot/heat control for bar, billet, tube, and rod manufacturing, as well as machined parts and customized components. Automating your testing with a Vanta iX analyzer adds value to your finished product since you can demonstrate that materials are 100% tested and verified.

Applications

- Foundry feed grade control
- 🛛 Alloy ID grade control (metal works)
- 🚔 GeoChem feed and Grade control
- Coating thickness (electronics and galvanised steel manufacturing)

Scanning and Monitoring for Geo Processing

For geological processing and mining, the Vanta iX analyzer enables monitoring for core scanning and on-belt analysis with real-time results to monitor process variability and ensure ore grade consistency. During on-belt analysis, the analyzer provides blending verification and process validation of concentrates.

Intelligent Integration

The Vanta[™] iX analyzer includes mounting holes that make it easy to attach to existing robotics and other systems. There is no external control box, so you can easily control the analyzer with either a PLC and discrete wire or through the Vanta Connect API.

Connector options:

- Ethernet (RJ-45), enabling Power over Ethernet
- USB
- Discrete I/O (16 pins)
- AUX DC power

Rugged for the Manufacturing Line

The Vanta iX analyzer is built to endure the high levels of vibration, electromagnetic and acoustical noise, dust, and moisture of production facilities.

- Vibration and mechanical shock tested (MIL-STD-810G)
- IP54 rated
- Designed to operate from -10 °C to 50 °C (14 °F to 122 °F) with continuous testing

A built-in heat sink lowers the internal temperature, while fan attachment points are available for additional cooling. The analyzer offers toolless window changes for fast maintenance.





Vanta[™] iX Specifications

Dimensions (W \times H \times D)	10 cm × 7.9 cm × 26.6 cm (3.9 in. × 3.1 in. × 10.5 in.)
Weight	2.4 kg (5.29 lb)
Excitation Source	X-ray tube: Rh or W anode (application optimized) 5–200 µA MR model: 8–50 keV (4 W max) CW model: 8–40 keV (4 W max)
Primary Beam Filtration	Eight filter positions automatically selected per beam per method
Detector	MR model: Large-area silicon drift detector CW model: Silicon drift detector
Power	Power over Ethernet (PoE+) or 18 V AC power adaptor
Elemental Range	Method dependent: MR model: Mg–U CW model: Ti–U (with standard window and calibration)
Pressure Correction	Built-in barometer for automatic altitude and air pressure correction
IP Rating	IP54
Operating Environment	Temperature range: –10 °C to 50 °C (14 °F to 122 °F) under continuous duty cycle Humidity: 10% to 90% relative humidity, non-condensing
Operating System	Linux
Application Software	Olympus proprietary data acquisition and processing package
Ruggedness Tested	Functional Shock: MIL-STD-810G, Method 516.6: Shock Procedure I, 20g 11ms (Op Safety), 40g 11ms (Crash Safety)
Vibration Resistance	MIL-STD-810G, Method 514.4: General Vibration, Procedure I, Annex C, Figure 514.6C-5, 1hr General Exposure
Transit Drop Tested	MIL-STD-810G, Method 516.6: Transit Drop, Procedure IV, 26 Drops

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